

<b>Notice of References Cited</b>	Application/Control No. 09/679,333	Applicant(s)/Pat nt Under Reexamination HEPPER ET AL.	
	Examiner Benjamin E Lanier	Art Unit 2132	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,360,364	03-2002	Chen et al.	711/169
	B	US-5,974,529	10-1999	Zumkehr et al.	712/41
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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